DATA SHEET



MOS FIELD EFFECT TRANSISTOR

NP88N04CHE, NP88N04DHE, NP88N04EHE

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance

 $R_{DS(on)} = 4.3 \text{ m}\Omega \text{ MAX.} (V_{GS} = 10 \text{ V}, \text{ ID} = 44 \text{ A})$

- Low C_{iss} : C_{iss} = 7300 pF TYP.
- Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage	VDSS	40	V
Gate to Source Voltage	Vgss	±20	V
Drain Current (DC) Note1	D(DC)	±88	А
Drain Current (Pulse) Note2	D(pulse)	±352	А
Total Power Dissipation ($T_A = 25^{\circ}C$)	Ρτ	1.8	W
Total Power Dissipation ($T_c = 25^{\circ}C$)	Ρτ	288	W
Single Avalanche Current Note3	las	75 / 88	А
Single Avalanche Energy ^{Note3}	Eas	562 / 232	mJ
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	-55 to +175	°C

Notes 1. Calculated constant current according to MAX. allowable channel

- temperature.
- **2.** PW \leq 10 μ s, Duty cycle \leq 1 %

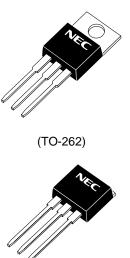
3. Starting $T_{ch} = 25 \text{ °C}$, $R_G = 25 \Omega$, $V_{GS} = 20 \text{ V} \rightarrow 0 \text{ V}$ (see Figure 4.)

THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	0.52	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

ORDERING INFORMATION

PART NUMBER	PACKAGE
NP88N04CHE	TO-220AB
NP88N04DHE	TO-262
NP88N04EHE	TO-263



(TO-263)



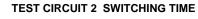
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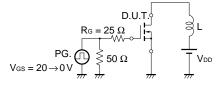
ELECTRICAL CHARACTERISTICS (TA = 25 °C)

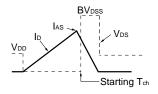
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 44 A		3.4	4.3	mΩ
Gate to Source Threshold Voltage	VGS(th)	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2.0	3.0	4.0	V
Forward Transfer Admittance	y _{fs}	Vds = 10 V, Id = 44 A	30	60		S
Drain Leakage Current	loss	$V_{DS} = 40 V, V_{GS} = 0 V$			10	μA
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Input Capacitance	Ciss	V _{DS} = 25 V		7300	11000	pF
Output Capacitance	Coss	Vgs = 0 V		1400	2100	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		620	1120	pF
Turn-on Delay Time	td(on)	I _D = 44 A		38	84	ns
Rise Time	tr	$V_{GS(on)} = 10 V$		27	68	ns
Turn-off Delay Time	td(off)	$V_{DD} = 20 V$		110	220	ns
Fall Time	tr	$R_G = 1 \Omega$		32	80	ns
Total Gate Charge	Q _G	ID = 88 A		120	180	nC
Gate to Source Charge	Q _{GS}	V _{DD} = 32 V		30		nC
Gate to Drain Charge	Qgd	Vgs = 10 V		43		nC
Body Diode Forward Voltage	VF(S-D)	IF = 88 A, VGs = 0 V		0.95		V
Reverse Recovery Time	trr	IF = 88 A, VGs = 0 V		64		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		99		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

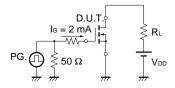


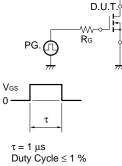
1

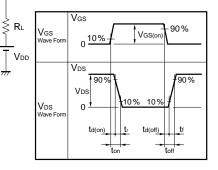




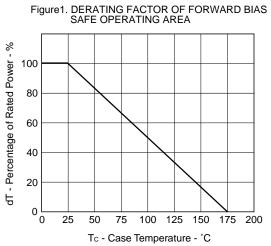
TEST CIRCUIT 3 GATE CHARGE



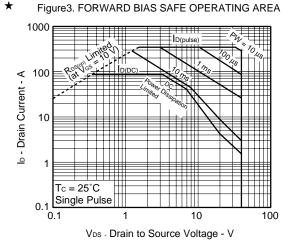


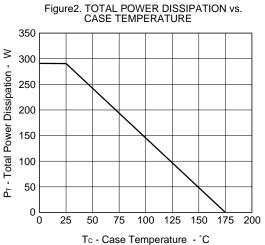


TYPICAL CHARACTERISTICS (TA = 25°C)

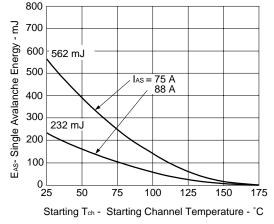




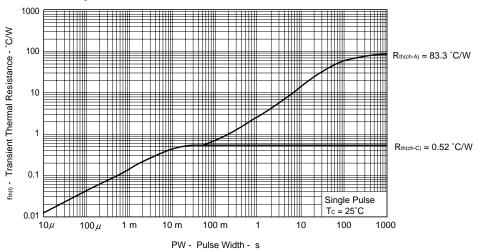






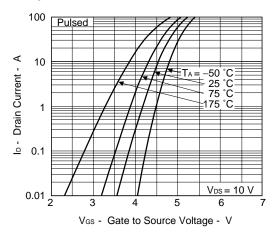




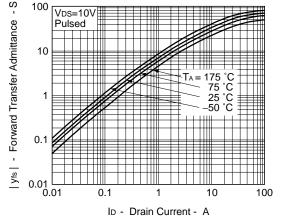


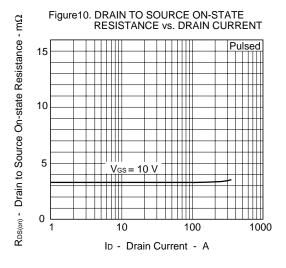
Data Sheet D14236EJ4V0DS

Figure6. FORWARD TRANSFER CHARACTERISTICS









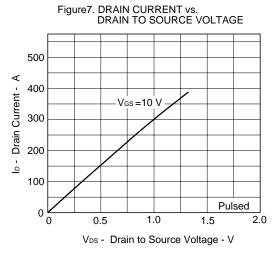


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

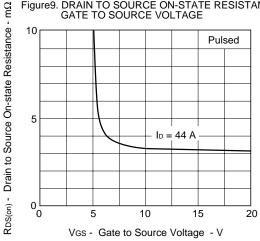
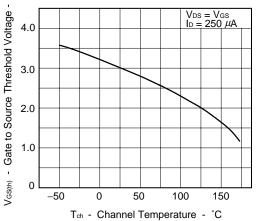
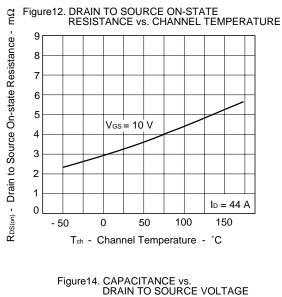
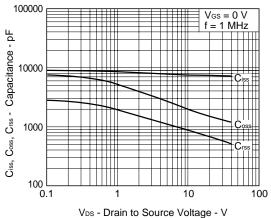


Figure11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE



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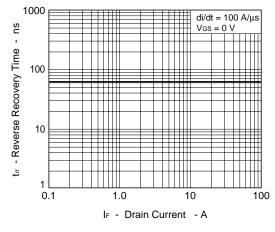


Figure13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE

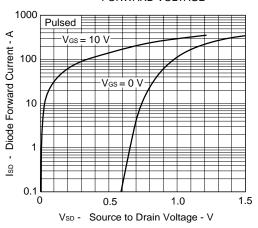


Figure 15. SWITCHING CHARACTERISTICS

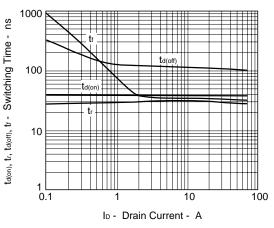
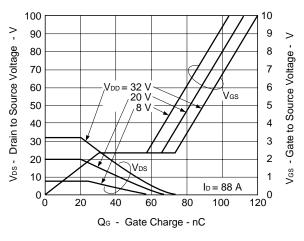
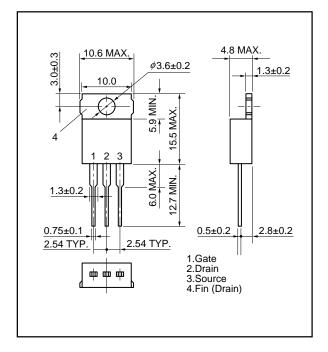


Figure17. DYNAMIC INPUT/OUTPUT CHARACTERISTICS

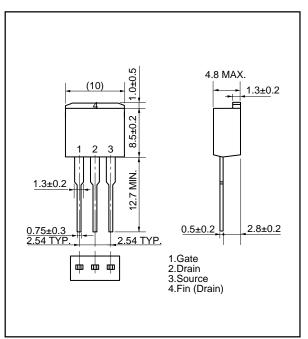


PACKAGE DRAWINGS (Unit: mm)

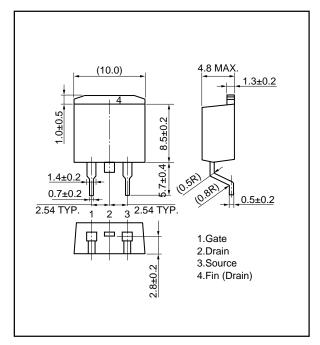
1) TO-220AB (MP-25)



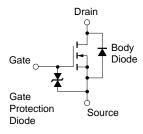




3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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